

# **Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under  
Reexamination  
MITOMO ET AL.

Examiner *QW 9-03*  
Quyen P. Leung

Art Unit  
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Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5568500	10-1996	Furuya et al	372/46
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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	K	US-			
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## **FOREIGN PATENT DOCUMENTS**

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## **NON-PATENT DOCUMENTS**

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